NIRMA UNIVERSITY SCHOOL OF TECHNOLOGY, INSTITUTE OF TECHNOLOGY

M. Tech. in Electronics and Communication Engineering (Embedded System)

M.Tech. Semester - II Department Elective III

L	T	Practical component				C
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Course Code	6EC276
Course Title	Testing and Verification of Embedded Systems

Course Learning Outcomes (CLOs):

At the end of the course, students will be able to -

- 1. Propose the verification architecture of given Embedded Systems.
- 2. Apply the concepts of hardware software co design from testing and verification point of view.
- 3. Design SoC test wrapper for embedded systems.
- 4. Perform testing on given embedded software components.

Syllabus: Teaching Hours:45				
UNIT I: Introduction 02				
Need of Testing, Different Roles of Testing, Cost and product considerations with reference				
to Testing				
UNIT II: Functional Verification Methods and Tools				
Concept, Test Bench Architecture, Test Bench Generation, Monitors, Checkers, Scoreboard,				
Verification Language, Simulation tools, Emulation, Functional and Code Coverage,				
Assertion based Verification				
UNIT III: Formal Verification Methods 04				
Binary Decision Diagram, Equivalence Checking, Model Checking				
UNIT IV: Challenges in Testing and Verification of Embedded Systems 05				
Design-for-Test, Built in Self-Test, Design-for-Manufacturing, Design-for-Upgrades, Over				
the Air Interface, Embedded System Test Jig Design, Testing of Asynchronous Systems				
UNIT V: SoC Testing 05				
Introduction to IP Testing-Memory Testing and FPGA Testing, Core Based Testing and Test				
Wrapper, SoC and Embedded System Testing				
UNIT VI: Embedded Software Testing 04				
Criteria for Embedded Software Testing, Methods and Tools of Software Testing, Validation,				
Unit Level Testing, Component Testing, Integrated Testing, System Level Testing				

Self-Study:

The self-study contents will be declared at the commencement of semester. Around 10% of the questions will be asked from self-study contents.

Laboratory Work:

Laboratory work will be based on above syllabus with minimum 10 experiments to be incorporated.

Suggested Readings:

- 1. Malvin A Breuer, Diagnosis and Reliable Design of Digital System, Computer Science Press
- 2. Laung-TerngWang, VLSI Test Principals and Architecture:, Morgan Kaufman
- 3. Bart Broekman, Edwi Notenboom, Testing Embedded Software, Pearson Education
- 4. Daniel W lewis, Fundamentals of Embedded Software: where C and Assembly meet, Prentice Hall
- 5. Michael L. Bushnell and Vishwani D. Agrawal Essential of Electronic Testing for Digital, Memory and Mixed Signal VLSI Circuits, Kluwer Academic Publishers